

# $R_{sh}/Q_0$ Measurements in Klystron Cavities

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**Abstract**—This paper presents the experimental results of  $R_{sh}/Q_0$  measurements in klystron cavities using the perturbation technique. The theory involving this technique results in an expression which depends on the natural frequency  $f_0$  and the perturbed frequency shift  $\Delta f$ , both measured using a cylindrical reentrant cavity with offset gap built in the laboratory. In addition, it is used a cylindrical cavity (pill-box) to calculate a constant that depends on the geometry of the perturbed object, as well as analytical expressions to calculate an integral factor that relates the square of the voltage on axis and the electric energy originally stored in the small volume of the perturbed object. The values measured of  $f_0$ ,  $\Delta f$  and  $R_{sh}/Q_0$  are, respectively, 2.86 GHz, - 5.27 MHz and 79.8  $\Omega$ . They are also compared with the results simulated by a 3D eigensolver obtaining a good agreement.

**Keywords** – Klystron cavity  $R_{sh}/Q_0$ , Slater's perturbation technique, cylindrical reentrant cavity, perturbed frequency shift.

## I. INTRODUCTION

The cavity  $R_{sh}/Q_0$  is one of the most important parameters to be determined in the design of a klystron amplifier. In this problem the gain of a klystron is proportional to the cavity shunt resistance  $R_{sh}$ , while bandwidth proportional to the cavity  $1/Q_0$ , so that  $R_{sh}/Q_0$  is a useful figure of merit in describing the effect of the each cavity on the gain-bandwidth product of overall amplifier. Therefore, it is relevant when, for example, one of the design requirements is high product gain-bandwidth. Moreover, since the  $R_{sh}/Q_0$  quantity is independent of cavity losses it is a very relevant figure of merit. Furthermore, it is dependent on the geometric shape of the cavity and frequency.

Although there are some electromagnetic field codes available now to calculate of the cavity  $R_{sh}/Q_0$ , the experimental measurements provide considerable insight on the role of a cavity and its gap [1]-[3] over the amplifier. Accordingly to Slater's perturbation theorem [4], when some parameters such as the configuration of the boundary, the material in the volume or the material of the boundary change slightly, the electromagnetic system is said to be perturbed. If the solution of an unperturbed problem is known, then the solution of the perturbed problem, which is slightly different from the unperturbed one, can be obtained by means of the principle of the perturbation. There are two possible ways to

do this: the cavity wall perturbation or the conductor perturbation of the cavity. The first one means to introduce a small deformation in the wall. The second one means to introduce a small conductive perturbing object into the cavity. In this work the latter technique is used, although the deformation of the wall may also be considered as a conductive perturbing object stuck on the wall.

Given a cavity at resonance, it is known that average stored magnetic and electric energies are equals. If a small perturbation is made by introducing a small conductive object into the cavity, this changes one type of energy more than the other, and resonant frequency would then shift by an amount necessary to equalize the energies again. The perturbation method assumes that the actual fields of a cavity with a small shape or material perturbation are not different from those of the unperturbed cavity. So, if the cavity frequency shift due to the small object can be measured as well its geometry shape, the Slater's perturbation theorem is useful to determine the cavity figure of merit  $R_{sh}/Q_0$ .

This paper is organized as follows. Section II presents the mathematical formulation of the problem. The description of the experiment setup and results are shown and discussed in Section III. Finally, the conclusion is presented in Section IV.

## II. MATHEMATICAL FORMULATION

The physical interest problem is constituted of a real resonant cavity considering small losses where the surface currents are essentially those associated with the loss-free field solutions. This cavity is formed by a surface  $S_0$  inclosing a volume  $V_0$ . It is considered, as an hypothesis, the volume of the perturbing object as being  $\Delta V$  and the surface enclosing the perturbing object as being  $\Delta S$ . The positive direction of  $\Delta S$  is the outward direction of the volume  $\Delta V$ . Here, the volume of the perturbed cavity is  $V$  and the surface enclosing it is  $S$ . Consider that the positive direction of  $S$  and  $S_0$  is the outward direction of the cavity volume  $V$  and  $V_0$ . Besides, it is considered  $S = S_0 - \Delta S$  and  $V = V_0 - \Delta V$ . Let  $\omega_0$ ,  $\vec{E}_0$  and  $\vec{H}_0$  represent the natural angular frequency, the electric and magnetic fields of the unperturbed cavity, respectively, and  $\omega$ ,  $\vec{E}$  and  $\vec{H}$  represent the corresponding quantities of the perturbed cavity. In both cases Maxwell's equations must be satisfied, that is

$$\nabla \times \begin{Bmatrix} \vec{E} \\ \vec{E}_0 \end{Bmatrix} = -j\mu_0 \begin{Bmatrix} \omega \vec{H} \\ \omega_0 \vec{H}_0 \end{Bmatrix}, \quad (1)$$

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$$\nabla \times \begin{Bmatrix} \vec{H} \\ \vec{H}_0 \end{Bmatrix} = j\varepsilon_0 \begin{Bmatrix} \omega \vec{E} \\ \omega_0 \vec{E}_0 \end{Bmatrix}, \text{ and} \quad (2)$$

where  $\varepsilon_0$  is the electric permittivity of free space and  $\mu_0$  is the magnetic permeability of the free space. The Maxwell's equations (1)-(2), conveniently manipulated [5] [6], result in the exact equation for the change in natural frequency due to the introduction of a conductive perturbing object into the cavity. Initially, one must multiply the complex conjugate of the second equation of (1) by  $\vec{H}$ , the first equation of (2) by  $\vec{E}_0^*$ , the complex conjugate of the second equation of (2) by  $\vec{E}$  and the first equation of (1) by  $\vec{H}_0^*$ , obtaining

$$\vec{H} \cdot \nabla \times \vec{E}_0^* = j\omega_0 \mu_0 \vec{H} \cdot \vec{H}_0^*, \quad (3)$$

$$\vec{E}_0^* \cdot \nabla \times \vec{H} = j\omega \varepsilon_0 \vec{E}_0^* \cdot \vec{E}, \quad (4)$$

$$\vec{E} \cdot \nabla \times \vec{H}_0^* = -j\omega_0 \varepsilon_0 \vec{E} \cdot \vec{E}^*, \text{ and} \quad (5)$$

$$\vec{H}_0^* \cdot \nabla \times \vec{E} = -j\omega \mu_0 \vec{H}_0^* \cdot \vec{H}. \quad (6)$$

Then, subtracting (4) from (3) and (6) from (5) and using the vector identity given by

$$\nabla \cdot (\vec{A} \times \vec{B}) = (\nabla \times \vec{A}) \cdot \vec{B} - (\nabla \times \vec{B}) \cdot \vec{A}, \quad (7)$$

it is possible to write

$$\nabla \cdot (\vec{E}_0^* \times \vec{H}) = j\omega_0 \mu_0 \vec{H} \cdot \vec{H}_0^* - j\omega \varepsilon_0 \vec{E}_0^* \cdot \vec{E}, \text{ and} \quad (8)$$

$$\nabla \cdot (\vec{E} \times \vec{H}_0^*) = j\omega_0 \varepsilon_0 \vec{E} \cdot \vec{E}^* - j\omega \mu_0 \vec{H}_0^* \cdot \vec{H}. \quad (9)$$

The next step is to add (8) and (9), integrate over the volume  $V$ , and use the divergence theorem to obtain

$$\oint_S (\vec{E} \times \vec{H}_0^* + \vec{E}_0^* \times \vec{H}) \cdot d\vec{s} = -j(\omega - \omega_0) \int_V (\varepsilon_0 \vec{E} \cdot \vec{E}_0^* + \mu_0 \vec{H} \cdot \vec{H}_0^*) dv. \quad (10)$$

Now, since  $\hat{n} \times \vec{E} = \vec{0}$  on  $S$ , expression (10) means that

$$\oint_S \vec{E}_0^* \times \vec{H} \cdot d\vec{s} = -j(\omega - \omega_0) \int_V (\varepsilon_0 \vec{E} \cdot \vec{E}_0^* + \mu_0 \vec{H} \cdot \vec{H}_0^*) dv. \quad (11)$$

In addition, since  $S = S_0 - \Delta S$  and  $\hat{n} \times \vec{E}_0 = 0$  on  $S_0$ , it is possible to write that

$$\oint_S \vec{E}_0^* \times \vec{H} \cdot d\vec{s} = \oint_{S_0} \vec{E}_0^* \times \vec{H} \cdot d\vec{s} - \oint_{\Delta S} \vec{E}_0^* \times \vec{H} \cdot d\vec{s} = -\oint_{\Delta S} \vec{E}_0^* \times \vec{H} \cdot d\vec{s}, \quad (12)$$

Finally, using (14) in (13) one gets to

$$\Delta\omega = \omega - \omega_0 = \frac{-j \oint_{\Delta S} \vec{E}_0^* \times \vec{H} \cdot d\vec{s}}{\int_V (\varepsilon_0 \vec{E} \cdot \vec{E}_0^* + \mu_0 \vec{H} \cdot \vec{H}_0^*) dv}. \quad (13)$$

For practical application of (13) and once that  $\vec{E}$ ,  $\vec{H}$ , or  $\omega$  are not generally known, it must replace these unknown perturbed quantities by the unperturbed fields  $\vec{E}_0$  and  $\vec{H}_0$ , besides  $\omega_0$ . For small perturbations, when  $\Delta S$  is small, this is certainly reasonable and the denominator results

$$\int_V (\varepsilon_0 \vec{E} \cdot \vec{E}_0^* + \mu_0 \vec{H} \cdot \vec{H}_0^*) dv \approx \int_V (\varepsilon_0 E_0^2 + \mu_0 H_0^2) dv. \quad (14)$$

In the numerator, the tangential component of the perturbed magnetic field is, approximately, equal to the unperturbed value when the conductive perturbing object is small. Then, it is possible to write that

$$\oint_{\Delta S} \vec{E}_0^* \times \vec{H} \cdot d\vec{s} \approx \oint_{\Delta S} \vec{E}_0^* \times \vec{H}_0 \cdot d\vec{s} = \int_{\Delta V} \nabla \cdot (\vec{E}_0^* \times \vec{H}_0) dv. \quad (15)$$

Equation (15) can be written any other way. First, one must multiply the complex conjugate of the second equation of (1) by  $\vec{H}_0$ , and the second equation of (2) by  $\vec{E}_0^*$ , obtaining

$$\vec{H}_0 \cdot \nabla \times \vec{E}_0^* = j\omega_0 \mu_0 H_0^2, \text{ and} \quad (16)$$

$$\vec{E}_0^* \cdot \nabla \times \vec{H}_0 = j\omega_0 \varepsilon_0 E_0^2. \quad (17)$$

Then, subtracting (17) from (16) and using the vector identity (7) it is possible to write that

$$\nabla \cdot (\vec{E}_0^* \times \vec{H}_0) = j\omega_0 \mu_0 H_0^2 - j\omega_0 \varepsilon_0 E_0^2. \quad (18)$$

Therefore, (15) can be rewritten as

$$\int_{\Delta V} \nabla \cdot (\vec{E}_0^* \times \vec{H}_0) dv = j\omega_0 \int_{\Delta V} (\mu_0 H_0^2 - \varepsilon_0 E_0^2) dv. \quad (19)$$

Substituting (14) and (19) into (13), it obtains

$$\frac{\Delta\omega}{\omega_0} \approx \frac{\int_{\Delta V} (\mu_0 H_0^2 - \varepsilon_0 E_0^2) dv}{\int_V (\varepsilon_0 E_0^2 + \mu_0 H_0^2) dv}. \quad (20)$$

This is the perturbation equation for conductor perturbation of a cavity. It is verified that the denominator is proportional to the total energy stored in the cavity, whereas the terms in the numerator are proportional to the electric and magnetic energies removed by the perturbation. Then, (20) can be rewritten as

$$\frac{\Delta\omega}{\omega_0} \approx \frac{\Delta W_m - \Delta W_e}{2W}, \quad (21)$$

where  $W$  denotes the total energy stored in the original cavity, and  $\Delta W_m$  and  $\Delta W_e$  denote the time average magnetic energy and electric energy, respectively, originally stored in the small volume  $\Delta V$ . The perturbation equation shows that the introduction of a conductive perturbing object into the cavity will raise the natural frequency if it is made at a point with large magnetic field (high  $W_m$ ) and small electric field (low  $W_e$ ), and will lower the natural frequency if it is made at a point with large electric field (high  $W_e$ ) and small magnetic field (low  $W_m$ ).

The perturbation formulae (20) or (21) are valid only when the introduction of the perturbing object does not influence the fields outside the perturbing body. Otherwise, the perturbation formula must be modified as follows

$$\frac{\Delta\omega}{\omega_0} = K \frac{\int_{\Delta V} (\mu_0 H_0^2 - \varepsilon_0 E_0^2) dv}{\int_V (\varepsilon_0 E_0^2 + \mu_0 H_0^2) dv} = K \frac{\Delta W_m - \Delta W_e}{2W}, \quad (22)$$

where  $K$  is a constant and depends upon the shape of the perturbing object and the orientation of it in the fields. This perturbation constant  $K$  may be obtained by means of experiment.

In terms of the resonant frequency  $f_0$  and the perturbed frequency shift  $\Delta f$  due to application of the method of perturbation it is possible, from (22), to write that

$$\Delta f = \frac{K f_0}{4W} \int_{\Delta V} (\mu_0 H_0^2 - \varepsilon_0 E_0^2) dv, \quad (23)$$

for small perturbations and where  $4W$  is due to the fact that

$$W = \frac{1}{2} \int_V (\varepsilon_0 E_0^2 + \mu_0 H_0^2) dv. \quad (24)$$

In  $TM_{010}$  klystron cavities, only the electric field is present along the cavity axis. Besides, experimentally, it is used the concept of the Slater's perturbation theorem, which states that, considering a small perturbing object along the axis, the magnetic field can be negligible [7] and the perturbed frequency shift, from (24), can be written as

$$\frac{\Delta f}{f_0} = -\frac{K\epsilon_0}{4W} \int_{\Delta V} [E_z(f_0, r, z)]^2 dv. \quad (25)$$

The cavity  $R_{sh}/Q_0$ , a figure of merit relating the resonant structure with its ability in doing work on an electron beam, is defined as the ratio of the shunt impedance  $R_{sh}$  of the cavity, in case of klystron cavities, given by

$$R_{sh} = \frac{\left[ \int_{axis} \vec{E} \cdot d\vec{l} \right]^2}{2P_L} = \frac{\left[ \int_{-\infty}^{+\infty} E_z(f_0, 0, z) dz \right]^2}{2P_L}, \quad (26)$$

and the unloaded quality factor  $Q_0$ , given by

$$Q_0 = \frac{\omega_0 W}{P_L}, \quad (27)$$

where  $P_L$  is the power loss on the cavity walls [8]. Combining (26) and (27), one has

$$\frac{R_{sh}}{Q_0} = \frac{\left[ \int_{-\infty}^{+\infty} E_z(f_0, 0, z) dz \right]^2}{2\omega_0 W}. \quad (28)$$

Now, multiplying and dividing (28) by  $\int_{\Delta V} [E_z(f_0, r, z)]^2 dv$  results

$$\frac{R_{sh}}{Q_0} = \frac{\int_{\Delta V} [E_z(f_0, r, z)]^2 dv \left( \int_{-\infty}^{+\infty} E_z(f_0, 0, z) dz \right)^2}{2\omega_0 W \int_{\Delta V} [E_z(f_0, r, z)]^2 dv}. \quad (29)$$

Isolating the term  $\int_{\Delta V} [E_z(f_0, r, z)]^2 dv / 2\omega_0 W$  in (25) and substituting in (29), it is possible to write that

$$\frac{R_{sh}}{Q_0} = -\frac{\Delta f}{K\pi\epsilon_0 f_0^2} \frac{\left( \int_{axis} E_z(f_0, b, z) dz \right)^2}{\int_{\Delta V} [E_z(f_0, r, z)]^2 dv}. \quad (30)$$

The calculation of  $K$  is presented as the first result of the experiment in the next section. The integral ratio is obtained, experimentally, using the Slater's perturbation theorem.

### III. EXPERIMENT AND RESULTS

First of all, it is necessary to calculate  $K$ . For this, it is used a cylindrical cavity (pill-box) and a metallic perturbing cylinder as shown in the Fig. 1. Table I presents their dimensions.

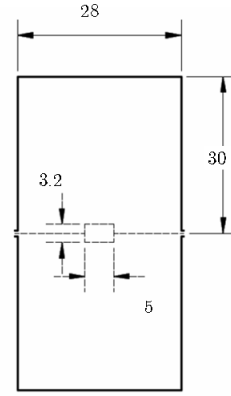


Fig. 1. Geometry and dimensions of the cylindrical cavity (pill-box) and perturbing object used in the perturbation method. The dimensions are in mm.

TABLE I. DIMENSIONS OF THE CYLINDRICAL CAVITY (PILL-BOX) AND THE METALLIC PERTURBING CYLINDER.

Quantity	Value
Cylindrical cavity length $L$ , mm	28
Cylindrical cavity radius $r_c$ , mm	30
Metallic perturbing cylinder length $L_p$ , mm	5.00
Metallic perturbing cylinder radius $r_p$ , mm	1.60
Volume of the perturbing object $\Delta V$ , mm <sup>3</sup>	40.21

If the perturbing object is placed along the axis of pill-box in the  $TM_{010}$  mode,  $R_{sh}/Q_0$  can be theoretically determined [8] [9] by

$$\frac{R_{sh}}{Q_0} = 185 \frac{L}{r_c} = -\frac{L^2 \Delta f}{K\pi\epsilon_0 \Delta V f_0^2}, \quad (31)$$

where the gap factor reduces to 1.0 because the electric field in a  $TM_{010}$  cylindrical cavity is constant across  $L$ . Thus,  $K$  becomes

$$K = -\frac{r_c L \Delta f}{185\pi\epsilon_0 \Delta V f_0^2}. \quad (32)$$

A metallic perturbing cylinder, shown in Fig. 2, was calibrated in this way using the cylindrical cavity shown in Fig. 1.

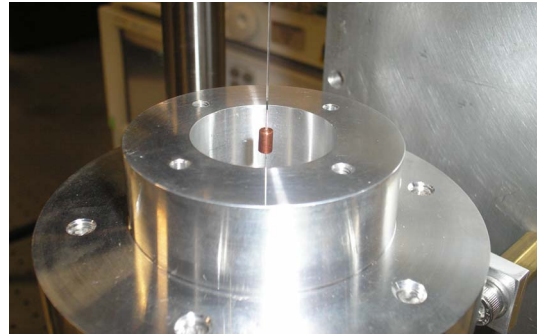


Fig. 2. Metallic perturbing cylinder used in the perturbation method.

The perturbation measurements starting point is the calibration of a port of the Agilent PNA N5230C Network Analyser used in the experiment. Next, the calibrated port of the network is connected to the coupling probe in the cavity, one should select the parameter  $S_{11}$  or  $S_{22}$  to find out the

frequency  $f_0$  without the perturbing object. Thereafter, the experiment is repeated with the metallic perturbing cylinder placed along the axis of a cavity and the perturbed frequency shift  $\Delta f$  is recorded. Substituting the experimental values of  $f_0$  and  $\Delta f$  in (32), besides the dimensions shown in Table I, one can find the value of  $K$ , presented in Table II. Moreover, a 3D eigensolver was used to simulate the cavity for comparison purposes.

TABLE II. RESULTS OF THE PERTURBATION METHOD APPLIED TO CALCULATE THE CAVITY  $R_{sh}/Q_0$  AND COMPARISON WITH THE QUANTITIES CALCULATED BY THE 3D EIGENSOLVER. IT WAS USED THE CYLINDRICAL CAVITY (PILL-BOX) SHOWN IN FIG. 2.

Quantity	Values	
	Experiment	3D eigensolver
Frequency $f_0$ , GHz	3.82551	3.82443
Perturbed frequency shift $\Delta f$ , MHz	-19.80	-21.42
Perturbation constant $K$	5.57	5.95

The next step is, using the klystron cavity built in the laboratory with dimensions as in Fig. 3 and the metallic perturbing cylinder, showed in the Fig. 2, to determine the  $R_{sh}/Q_0$  using the perturbation method. The reentrant cavity geometry is shown in Fig. 4.

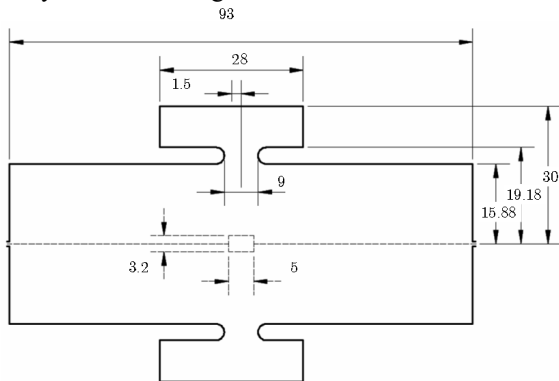


Fig. 3. Geometry and dimensions of the reentrant cavity used in the perturbation method. The dimensions are in mm.

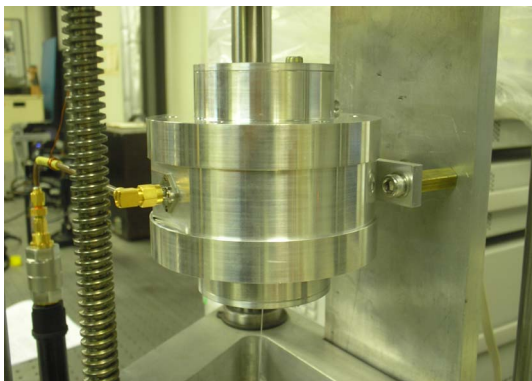


Fig. 4. Reentrant cavity built in laboratory which geometry and dimensions are presented in Fig.3.

The experimental setup is shown in Fig. 5. Initially, two copper foils of 0.2 mm thickness each were placed between the cavity body and the openings of the cavity, to act as electromagnetic chokes, in order to stop the electromagnetic leakage from the cavity. Then, following the same steps

described before, the first determination is the frequency  $f_0$  without the perturbing object. Actually, the perturbing object is kept all the time inside the cavity axis but, for this first measurement, its position is far enough from the center and, since the electric field is evanescent, it is considered that the field is negligible and the perturbing object does not affect the measurement.



Fig. 5. Experimental apparatus used in the calculation of the cavity  $R_{sh}/Q_0$  using the perturbation method.

Afterwards, the experiment is repeated with the metallic perturbing cylinder placed along the axis at the position where the perturbed frequency shift  $\Delta f$  is a maximum. This deviation can be seen in Fig. 6, which is the PNA display.

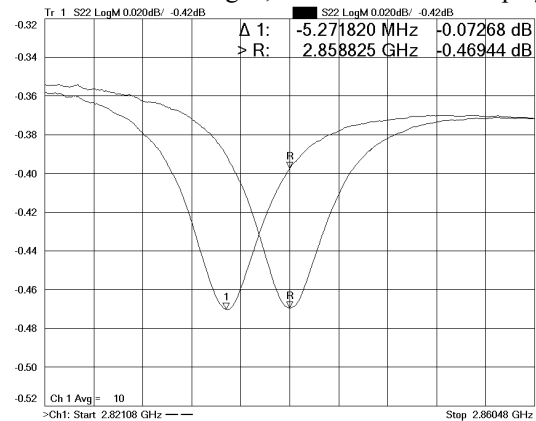


Fig. 6. The perturbed frequency shift  $\Delta f$  calculated by the perturbation method.

Furthermore, it is possible, using the concept of the Slater's perturbation theorem and the experiment, to plot the graph of the axial electric field along the cavity axis. The result is compared with the profile of the axial electric field in a cavity with offset gap considering a hyperbolic profile, according to the development presented in [9] and where the gap of interaction is symmetric with respect to the position  $z_g$  and the electric field in the gap region is considered as a combination of two functions: for  $z < z_g$  the electric field in the interaction gap has a hyperbolic profile given by  $E_M \cosh(q_1 z)$ , otherwise it has a hyperbolic profile given by  $E_M \cosh(q_2 z)$ , where  $E_M$  is the electric field amplitude,  $q_1$  and  $q_2$  are constants. Considering  $b$  as the drift tube radius, Fig. 7 shows the distribution of electric field in the axial coordinate of the gap ( $r=b$ ) and for some values inside the drift tube. It is possible to observe that it is an evanescent field.

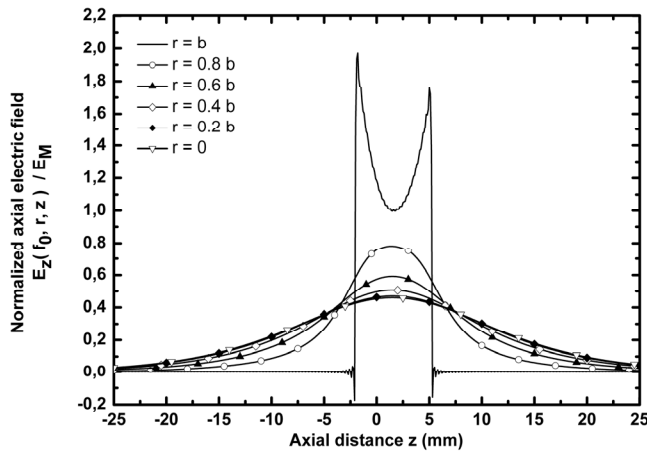


Fig. 7. Distribution of electric field in the axial coordinate of the gap ( $r=b$ ) and for some values inside the drift tube, considering the hyperbolic profile. It is observed that this field is evanescent [9].

The same result can also be obtained by simulating a klystron cavity using a 3D eigensolver. Fig. 8 shows the three results for  $r=0$ .

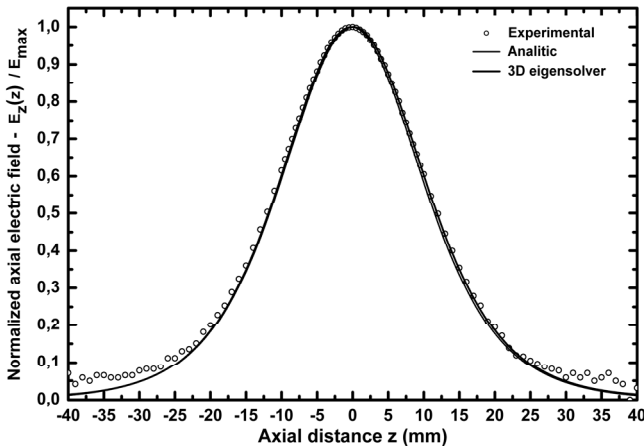


Fig. 8. Normalized axial electric field calculated experimentally and using, for comparison purposes, the 3D eigensolver and the analytic expression presented in [9].

Substituting the experimental values of  $f_0$ ,  $\Delta f$  and  $K$  in (30), besides the value of the integral ration obtained from the experimental results of the electric field shown in Fig. 8, one can find the value of cavity  $R_{sh}/Q_0$ , which is presented in Table III, together with the value calculated using the analytic expressions and the simulated result from the 3D eigensolver, both used for comparison purposes.

TABLE III. RESULTS OF THE PERTURBATION METHOD APPLIED TO CALCULATE THE CAVITY  $R_{sh}/Q_0$  AND COMPARISON WITH THE QUANTITIES CALCULATED USING THE ANALYTIC EXPRESSIONS AND THE 3D EIGENSOLVER. IT WAS USED THE REENRANT CAVITY SHOWN IN FIG. 4.

Quantity	Values		
	Experiment	Analytic	3D eigensolver
Frequency $f_0$ , GHz	2.859	2.875	2.872
Perturbed frequency shift $\Delta f$ , MHz	-5.27	-5.27	-5.90
Perturbation constant $K$	5.57	5.57	-----
Cavity $R_{sh}/Q_0$ , $\Omega$	79.8	74.9	79.7

The deviation between the experimental and the analytic value is around 6 % while the experimental and simulated value is less than 0.5 %, which demonstrates that the experimental procedure presented is very effective in measuring  $R_{sh}/Q_0$ .

It is interesting to observe the negative signal of the perturbed frequency shift  $\Delta f$ , which indicates that the presence of the perturbing object decreased the natural frequency. This phenomenon occurs when the perturbing object is put in a position with large electric field (high  $W_e$ ) and small magnetic field (low  $W_m$ ). This is exactly the case, confirmed by calculating the integral ratio using the analytic expressions without neglecting the magnetic field (23). It was obtained for cavity  $R_{sh}/Q_0$  the value of  $75.0 \Omega$ , less than 0.14 %. This result is interesting because it indicates that the calculation using only the electric field (magnetic field is negligible) is sufficient to have a good accuracy.

#### IV. CONCLUSION

In this work the results of a klystron cavity  $R_{sh}/Q_0$  using the perturbation measurements was presented. The  $R_{sh}/Q_0$  expression involves the natural frequency  $f_n$ , the perturbed frequency shift  $\Delta f$ , the perturbing constant  $K$  and the axis factor which relates the electric field along the cavity axis and the electric field in the volume of the perturbed object. The two first parameters were measured using a cylindrical reentrant cavity with offset gap built in the laboratory:  $f_0$  using an unperturbed cavity and  $\Delta f$  using the same cavity perturbed by a metallic perturbing cylinder. The perturbing constant  $K$  was calculated by measuring the same parameters mentioned above using a cylindrical cavity (pill-box). The integral ratio was obtained experimentally using the Slater's perturbation theorem. It was verified a good agreement between the cavity  $R_{sh}/Q_0$  obtained by the experiment and the values found with the analytic expressions and the 3D eigensolver as well.

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